

Search Notes**Application/Control No.**

10/562,769

Examiner

David J. Blanchard

**Applicant(s)/Patent under
Reexamination**

HEYWOOD ET AL.

Art Unit

1643

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
SEQ ID Nos:1-14 and 16-20		5/14/2009	DB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC search SEQ ID Nos:1-10 (results in SCORE)	5/14/2009	DB
STIC search SEQ ID Nos:11-14 and 16-20 (results in SCORE)	5/14/2009	DB
WEST, STN - medline, embase, esbiobase, scisearch, lifesci, biosis, biotechno, dissabs, inventor search (see notes)	5/14/2009	DB